

## **REGULATORY COMPLIANCE**











#### **ITEM DESCRIPTION**

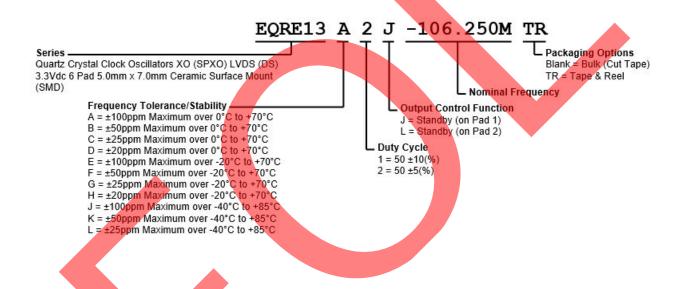
Quartz Crystal Clock Oscillators XO (SPXO) LVDS (DS) 3.3Vdc 6 Pad 5.0mm x 7.0mm Ceramic Surface Mount (SMD)

ELECTRICAL SPECIFICAT	ELECTRICAL SPECIFICATIONS		
Nominal Frequency	10MHz to 200MHz		
Frequency Tolerance/Stability	Inclusive of all conditions: Calibration Tolerance (at 25°C), Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration ±100ppm Maximum over 0°C to +70°C ±50ppm Maximum over 0°C to +70°C ±25ppm Maximum over 0°C to +70°C ±20ppm Maximum over -20°C to +70°C ±50ppm Maximum over -20°C to +70°C ±50ppm Maximum over -20°C to +70°C ±25ppm Maximum over -20°C to +70°C ±20ppm Maximum over -20°C to +70°C ±20ppm Maximum over -40°C to +85°C ±50ppm Maximum over -40°C to +85°C ±50ppm Maximum over -40°C to +85°C ±25ppm Maximum over -40°C to +85°C		
Aging at 25°C	±3ppm Maximum First Year		
Supply Voltage	3.3Vdc ±5%		
Input Current	30mA Maximu <mark>m</mark>		
Output Voltage Logic High (V <sub>Oh</sub> )	1.43Vdc Typical, 1.6Vdc Maximum		
Output Voltage Logic Low (Vol)	1.1Vdc Typical, 0.9Vdc Minimum		
Differential Output Error (dVod)	50mV Maximum		
Differential Output Voltage (Vod)	247mV Minimum, 330mV Typical, 454mV Maximum		
Offset Voltage (Vos)	1.125V Minimum, 1.250V Typical, 1.375V Maximum		
Rise/Fall Time	Measured at 20% to 80 <mark>% of Wavef</mark> orm 400pSec Maximum		
Duty Cycle	Measured at 50% of Waveform 50 ±10(%) 50 ±5(%)		
Offset Error (dVos)	50mV Maximum		
Load Drive Capability	100 Ohms Between Output and Complementary Output		
Output Logic Type	LVDS		
Phase Noise	All Values are Typical -50dBc/Hz at 10Hz Offset -82dBc/Hz at 100Hz Offset -116dBc/Hz at 1kHz Offset -138dBc/Hz at 10kHz Offset -144dBc/Hz at 10kHz Offset -144dBc/Hz at 100kHz Offset -149dBc/Hz at 1MHz Offset -155dBc/Hz at 10MHz Offset -155dBc/Hz at 20MHz Offset		
Output Control Function	Standby (on Pad 1) Standby (on Pad 2)		
Output Control Input Voltage Logic High (Vih)	70% of Vdd Minimum or No Connect to Enable Output and Complementary Output		
Output Control Input Voltage Logic Low (Vil)	30% of Vdd Maximum to Disable Output and Complementary Output (High Impedance)		
Standby Output Enable Time	10mSec Maximum		



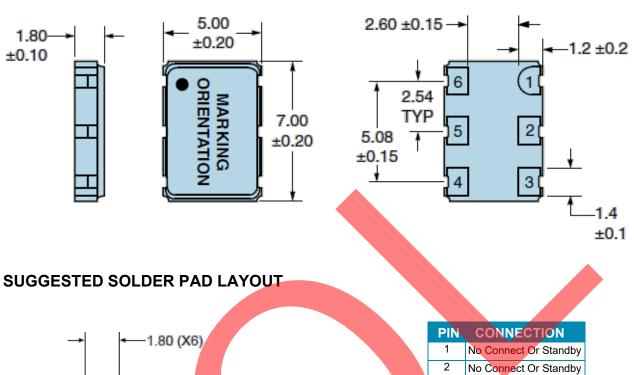
Standby Output Disable Time	200nSec Maximum
Standby Current	Without Load
	10μA Maximum
RMS Phase Jitter	Fj=12kHz to 20MHz (Random)
	600fSec Maximum over Nominal Frequency of 10MHz to 50MHz
	450fSec Maximum over Nominal Frequency of 50.000001MHz to 99.999999MHz
	200fSec Maximum over Nominal Frequency of 100MHz to 200MHz
Period Jitter (Deterministic)	0.2pSec Typical
Period Jitter (Random)	1.0pSec Typical
Period Jitter (One Sigma)	1.5pSec Typical
Period Jitter (tp-p)	40pSec Maximum
Start Up Time	10mSec Maximum
Storage Temperature Range	-55°C to +125°C

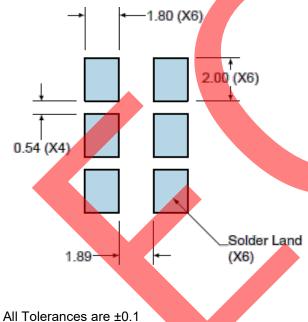
#### **PART NUMBERING GUIDE**





#### **MECHANICAL DIMENSIONS**



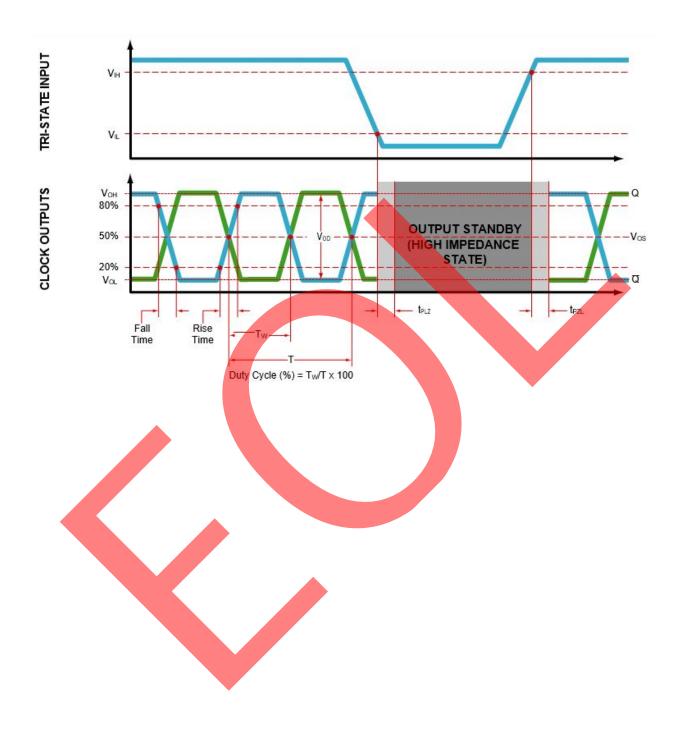


PIN	CONNECTION
1	No Connect Or Standby
2	No Connect Or Standby
3	Case/Ground
4	Output
5	Complementary Output
6	Supply Voltage

**All Dimensions in Millimeters** 

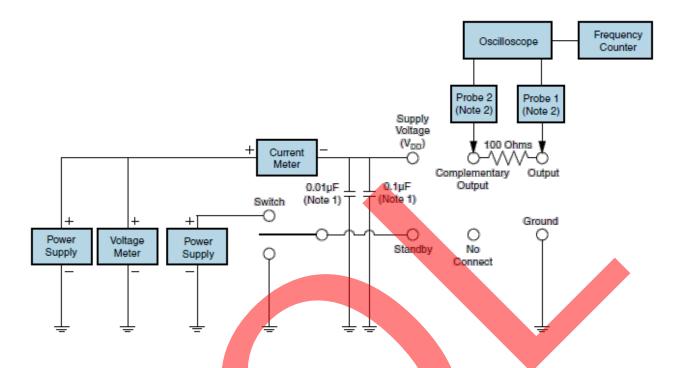


## **OUTPUT WAVEFORM & TIMING DIAGRAM**





## **TEST CIRCUIT FOR STANDBY (PAD 1) AND COMPLEMENTARY OUTPUT**



Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close to (Less than 2mm) the package ground and supply voltage pin is required.

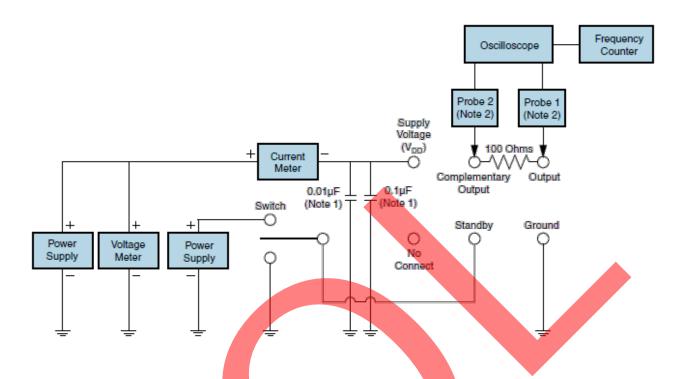
Note 2: A low capacitance (<12pF), 10X Attentuation Factor, High Impedance (>10Mohms), and High bandwidth (>500MHz) Passive probe is recommended.

Note 3: Test circuit PCB traces need to be designed for a characteristic line impedance of 50 ohms.





## **TEST CIRCUIT FOR STANDBY (PAD 2) AND COMPLEMENTARY OUTPUT**



Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close to (less than 2mm) the package ground and supply voltage pin is required.

Note 2: A low capacitance (<12pF), 10X Attentuation Factor, High Impedance (>10Mohms), and High bandwidth (>500MHz)

Passive probe is recommended.

Note 3: Test circuit PCB traces need to be designed for a characteristic line impedance of 50 ohms.





#### **TAPE & REEL DIMENSIONS**

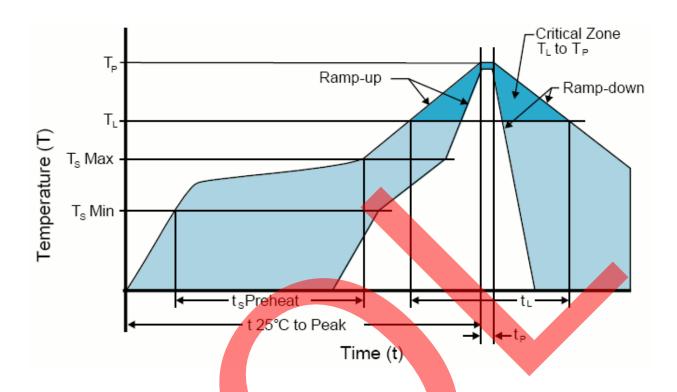
Quantity per Reel: 1000 Units

All Dimensions in Millimeters
Compliant to EIA-481

4.00 ±0.10 -0.60 MAX -DIA 1.50 +0.10/-0.00 0.10 MAX 2.00 ±0.10 1.75 ±0.10 7.50 ±0.10 16.00 ±0.30 B0 DIA 1.50 MIN - 8.00 ±0.10 → -A0 **Direction of Unreeling** 1.50 MIN-22.40 MAX DIA 40 MIN Access Hole at Slot Location 360 MAX DIA 50 MIN 2.50 MIN Width 10 MIN Depth **DIA 20.20 MIN** Tape slot in Core for Tape Start 16.40 +2.00/-0.00 -DIA 13.00 ±0.20



## **RECOMMENDED SOLDER REFLOW METHOD**



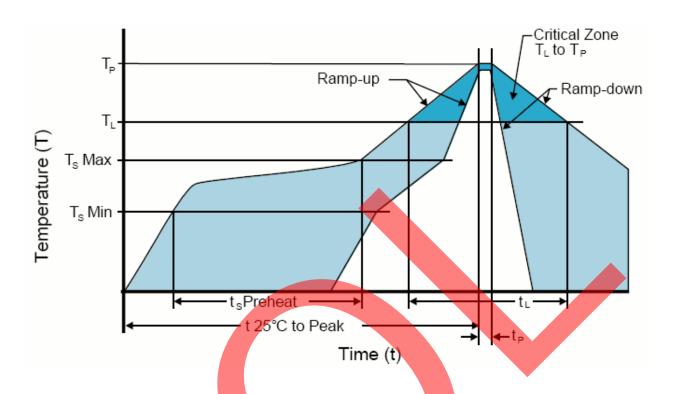
HIGH TEMPERATURE INFRARED/CONVECTION			
T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	3°C/Second Maximum		
Preheat			
- Temperature Minimum (Ts MIN)	150°C		
- Temperature Typical (Ts TYP)	175°C		
- Temperature Maximum(T <sub>s</sub> MAX)	200°C		
- Time (t <sub>s</sub> )	60 - 180 Seconds		
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	3°C/Second Maximum		
Time Maintained Above:			
- Temperature (T <sub>L</sub> )	217°C		
- Time (t <sub>L</sub> )	60 - 150 Seconds		
Peak Temperature (T <sub>P</sub> )	260°C Maximum for 10 Seconds Maximum		
Target Peak Temperature(T <sub>P</sub> Target)	250°C +0/-5°C		
Time within 5°C of actual peak (tp)	20 - 40 Seconds		
Ramp-down Rate	6°C/Second Maximum		
Time 25°C to Peak Temperature (t)	8 Minutes Maximum		
Moisture Sensitivity Level	Level 1		
Additional Notes	Temperatures shown are applied to body of device.		

#### **High Temperature Manual Soldering**

260°C Maximum for 5 Seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)



## **RECOMMENDED SOLDER REFLOW METHOD**



LOW TEMPERATURE INFRARED/CONVECTION			
T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/Second Maximum		
Preheat			
- Temperature Minimum (T <sub>s</sub> MIN)	N/A		
- Temperature Typical (T <sub>s</sub> TYP)	150°C		
- Temperature Maximum(T <sub>s</sub> MAX)	N/A		
- Time (t <sub>s</sub> )	60 - 120 Seconds		
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	5°C/Second Maximum		
Time Maintained Above:			
- Temperature (T <sub>L</sub> )	150°C		
- Time (t <sub>L</sub> )	200 Seconds Maximum		
Peak Temperature (T <sub>P</sub> )	240°C Maximum		
Target Peak Temperature (T <sub>P</sub> Target)	240°C Maximum 2 Times / 230°C Maximum 1 Time		
Time within 5°C of actual peak (tp)	10 Seconds Maximum 2 Times / 80 Seconds Maximum 1 Time		
Ramp-down Rate	5°C/Second Maximum		
Time 25°C to Peak Temperature (t)	N/A		
Moisture Sensitivity Level	Level 1		
Additional Notes	Temperatures shown are applied to body of device.		

#### **Low Temperature Manual Soldering**

185°C Maximum for 10 Seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)